Shot noise of quantum ring excitons in a planar microcavity

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Shot noise of quantum ring (QR) excitons in a p-i-n junction surrounded by a microcavity is investigated theoretically. Some radiative decay properties of a QR exciton in a microcavity can be obtained from the observation of the current noise, which also gives the extra information about the tunnel barriers. Dierent noise feature between the quantum dot (QD) and QR is pointed out, and may be observed in a suitably designed experiment.

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Since Purcell proposed the idea of controlling the spontaneous em ission rate by using a cavity [1], the enhanced and inhibited SE rate for the atom ic system was intensively investigated in the 1980s [2] by using atom spassed through a cavity. In sem iconductor system s, the electronhole pair is naturally a candidate to exam ine the spontaneous em ission. Modications of the SE rates of the QD [3], quantum wire [4], or quantum well [5] excitons inside the microcavities have been observed experimentally.

Recently, interest in measurements of shot noise spectrum has risen owing to the possibility of extracting valuable information not available in conventional dc transport experiments [6]. With the advances of fabrication technologies, it is now possible to embed the QDs inside a p-i-n structure [7], such that the electron and hole can be injected separately from the opposite sides. This allows one to examine the exciton dynamics in a QD via electrical currents. [8] On the other hand, it is now possible to fabricate the ring-shaped dots of InAs in GaAs with a circum ference of several hundred nanometers [9]. Optical detection of the Aharonov-Bohme ect on an exciton in a single QR was also reported [10].

B ased on the rapid progress of nano-technologies, it's not hard to imagine that the QR can be incorporated in a p-i-n junction surrounded by the microcavity. Exam inations of the dynam ics of the QR excitons by the electrical currents can soon be realized. We thus present in this work the non-equilibrium calculations of such a device. Current noise of QR excitons in a planar microcavity is obtained via the MacDonald formula [11], and is found to reveal some characteristics of the restricted environment, i.e. the density of states of the conned photons.

The model. | Consider now a QR embedded in a p-in junction as shown in Fig. 1. Both the hole and electron reservoirs are assumed to be in thermal equilibrium. For the physical phenomena we are interested in, the fermilevel of the p(n)-side hole (electron) is slightly lower (higher) than the hole (electron) subband in the dot. After a hole is injected into the hole subband in the QR, the n-side electron can tunnel into the exciton level because of the Coulomb interaction between the electron and hole. Thus, we may introduce the three ring states: $\mathfrak{D}i = \mathfrak{D}; hi, \mathfrak{J}^i i = \mathfrak{p}; hi, and \mathfrak{J}^i = \mathfrak{D}; 0i, where \mathfrak{D}; hi means there is one hole in the QR, <math>\mathfrak{p}; hi$ is the exciton state, and $\mathfrak{D}; 0i$ represents the ground state with no hole

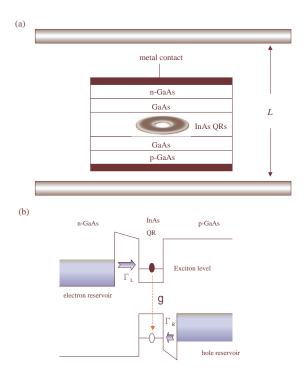


FIG. 1: (Color online). (a) Schematic description of a QR inside a p-i-n junction surrounded by a planar microcavity with length L. (b) Energy-band diagram of a QR in the p-i-n junction.

and electron in the QR.One might argue that one can not neglect the state je;0i for real device since the tunable variable is the applied voltage. This can be resolved by fabricating a thicker barrier on the electron side so that there is little chance for an electron to tunnel in advance. Moreover, the charged exciton and biexcitons states are also neglected in our calculations. This means a low injection limit is required in the experiment[7].

Derivation of M aster equation. | We can now de ne the ring-operators \hat{n}_* j"ih"j; \hat{n}_* j"ih#j; \hat{p}_* j"ih#j; \hat{s}_* jDih"j; \hat{s}_* jDih#j. The totalH am iltonian H of the system consists of three parts: H $_0$ [ring, photon bath H $_p$, and the electron (hole) reservoirs H $_{res}$], H $_T$ (ring-photon coupling), and the ring-reservoir coupling H $_V$:

In the above equation, b_k is the photon operator, D_k is the dipole coupling strength, $X = \bigcup_k D_k b_k^V$, and c_q and d_q denote the electron operators in the left ad right reservoirs, respectively. The couplings to the electron and hole reservoirs are given by the standard tunnel Ham iltonian H_V ; where V_q and W_q couple the channels q of the electron and the hole reservoirs. If the couplings to the electron and the hole reservoirs are weak, then it is reasonable to assume that the standard Bom-Markov approximation with respect to these couplings is valid. In this case, one can derive a master equation from the exact time-evolution of the system. The equations of motion can be expressed as (cf. [12])

$$\frac{\theta}{\theta t} \hat{n}_{i} \hat{i}_{t} = \int_{0}^{z} dt^{0} [C(t t^{0}) + C(t t^{0})] \hat{n}_{i} \hat{i}_{t^{0}}$$

$$+ \int_{1}^{z} [1 \hat{n}_{i} + \hat{n}_{i} \hat{i}_{t}] \qquad (2)$$

$$\begin{array}{ll} \frac{\theta}{\theta t} \hat{p} i_t = & \frac{1}{2} \\ \end{array} \begin{array}{ll} \frac{P}{q} V_q^2 & \text{(". ""_q)} \\ \end{array} , \quad _R = 2 \\ \end{array} \begin{array}{ll} \frac{P}{q} V_q^2 & \text{(". ""_q)} \\ \end{array} , \quad _R = 2 \\ \end{array} \begin{array}{ll} \frac{P}{q} W_q^2 & \text{(". ""_q)} \\ \end{array} , \quad _R = 2 \\ \end{array} \begin{array}{ll} \frac{P}{q} W_q^2 & \text{(". ""_q)} \\ \end{array} \begin{array}{ll} \frac{$$

$$Z_{1}$$
 $C_{"}(z)$
 z^{0}_{1}
 $c_{"}(z)$
 $c_{"}($

$$n_{"}(z) = (C_{"}(z) + C_{"}(z))n_{"}(z) = z$$

$$+ \frac{L}{z} (1 = z \quad n_{"}(z) \quad n_{\#}(z))$$

$$n_{\#}(z) = (C_{"}(z) + C_{"}(z))n_{\#}(z) = z \quad \frac{R}{z}n_{\#}(z)$$

$$p(z) = \frac{1}{2} (C_{"}(z) + C_{"}(z))p(z) = z \quad \frac{R}{2z}p(z) : (4)$$

These equations can then be solved algebraically, and the tunnel current from the hole-or electron-side barrier

$$\hat{I}_{R} = e_{R} \hat{m}_{\#} \hat{i}_{\#}; \hat{I}_{L} = e_{L} [1 \quad \hat{m}_{\#} \hat{i}_{\#}]$$
 (5)

can then be obtained by perform ing the inverse Laplace transform ation on Eqs. (4).

Shot noise spectrum. In a quantum conductor in nonequilibrium, electronic current noise originates from the dynamical uctuations of the current being away from its average. To study correlations between carriers, we relate the exciton dynamics with the hole reservoir operators by introducing the degree of freedom n as the number of holes that have tunneled through the hole-side barrier [13] and write

$$n_{0}^{(n)}(t) = {}_{L}n_{0}^{(n)}(t) + {}_{R}n_{\#}^{(n-1)}(t);$$

$$n_{\pi}^{(n)}(t) + n_{\#}^{(n)}(t) = ({}_{L} {}_{R})n_{0}^{(n)}(t):$$
(6)

Eqs. (6) allow us to calculate the particle current and the noise spectrum from P_n (t) = $n_0^{(n)}$ (t) + $n_*^{(n)}$ (t) + $n_\#^{(n)}$ (t) which gives the total probability of nding n electrons in the collector by time t. In particular, the noise spectrum $S_{\rm I_R}$ can be calculated via the M acD onald formula [14]. In the zero-frequency limit, the Fano factor can be written as

$$F = \frac{S_{I_R} (! = 0)}{2 \text{ehli}}$$

$$= 1 \frac{A(z)_{L R} [A(z) + 2(_{L} + _{R})]}{fA(z)_{R} + _{L} [A(z = 0) + 2_{R}] g^{2}}$$

$$= 1 \frac{A(z)_{L R} [A(z) + 2(_{L} + _{R})]}{fA(z)_{R} + _{L} [A(z = 0) + 2_{R}] g^{2}}$$

where A (z) $C_{"}(z) + C_{"}(z)$.

Results and D iscussions. \mid From Eq. (7), one knows that the noise spectrum of the QR excitons depends strongly on C_"(z), which reduces to the radiative decay rate in the M arkovian lim it. The exciton decay rate in a m icrocavity can be obtained easily from the perturbation theory and is given by

$$= \frac{e^{2}h}{m^{2}c^{2}d} \xrightarrow{Z} H_{0}^{(1)}(q^{0})^{2}q^{0}$$

$$X = \frac{x}{(m^{2}c^{2}q^{2} + k_{z}^{2})} + \frac{y}{k_{z}^{2} + q^{2}} + \frac{y}{q^{0}k_{z}^{0}} \qquad {}^{2})dq^{0}; \quad (8)$$

where is the ring radius, d is the lattice spacing, H $_0^{(1)}$ is the Hankel function, $_{q^0k_2^0}$ is the polarization of the photon, and is the dipole m oment of the QR exciton. [15] The sum mation of the integer modes in the k_2^0 direction is determined from the boundary conditions of the planar microcavity.

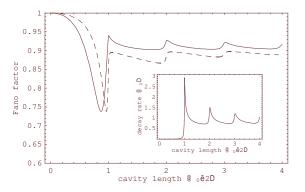


FIG. 2: Fano factor as a function of cavity length L. The vertical and horizontal units are $\frac{\text{S I}_R(0)}{2\text{eI}}$ and $_0$ =2, respectively. The inset shows the radiative decay rate of a QR exciton in a planar microcavity.

The radiative decay rate of a QR exciton inside a planar microcavity is numerically displayed in the inset of Fig. 2. The tunneling rates, $_{\rm L}$ and $_{\rm R}$, are assumed to be equal to 0.1 $_{0}$ and $_{0}$, where $_{0}$ (1/1ns) is the decay rate of a QR exciton in free space. Also, the planar m icrocavity is assumed to have a Lorentzian broadening at each resonant mode (with broadening width equals to 1% of each resonant mode). [16] As the cavity length is shorter than one half the wavelength of the emitted photon (L < $_0$ =2), the decay rate is inhibited because of the cut-o frequency of the cavity. When the cavity length exceeds som e multiple wavelength, it opens up another decay channel for the quantum ring exciton and turns out that there is an abrupt enhancem ent on the decay rate. Such a singular behavior also happens in the decay of one dim ensional quantum wire polaritons inside a m icrocavity. [16] This is because the ring geometry preserves the angular m om entum of the exciton, rendering the form ation of exciton-polariton in the direction of circum ference. This kind of behavior can also be found in the calculations of Fano factor as demonstrated by the solid line in Fig. 2. Comparing to the zero-frequency noise of the QD excitons (dashed line), the Fano factor of the QR excitons shows the "cusp" feature at each resonant m ode.

A nother interesting point is that below the lowest resonant mode (L = $_0$ =2), both the solid and dashed curves have a dip in the Fano factor. It is not seen from the radiative decay rate. To answer this, we have plotted Eq. (7) in Fig. 3 as a function of the decay rate . K eeping $_{\rm R}$ unchanged, the solid, dashed, and dasheddotted lines correspond to the electron-side tunneling rate $_{\rm L}$ = 0.01 $_0$;0.5 $_0$, and 0.1 $_0$, respectively. As can be seen, the Fano factor has a minimum point at $_{\rm L}$

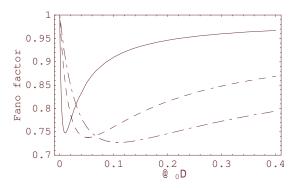


FIG .3: Fano factor as a function of the decay rate for di erent electron-side tunneling rate: $_{\rm L}$ = 0.01 $_{\rm 0}$ (solid line), 0.05 $_{\rm 0}$ (dashed line), and 0.1 $_{\rm 0}$ (dashed-doted line). The hole-side tunneling rate is xed ($_{\rm R}$ = $_{\rm 0}$).

 $_{\rm L}$ R ($_{\rm L}$ + $_{\rm R}$)=($_{\rm L}^2$ + $_{\rm R}^2$). Comparing this with the inset of Fig. 2, one immediately knows that when the cavity length is increased to $_{\rm 0}$ =2, the abruptly increased decay rate will cross the m inimum point and result in a dip in Fig. 2. Furthermore, in the limit of $_{\rm R}$ >> $_{\rm L}$, the minimum point can be approximated as: $_{\rm L}$. This means by observing the dip in the Fano factor of Fig. 2, the magnitude of the electron-side tunneling rate $_{\rm L}$ can be obtained.

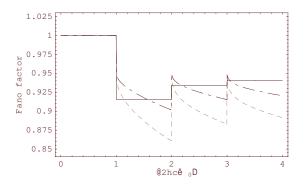


FIG. 4: (Color online). Fano factor of QD (solid line) and QR (gray dashed line) excitons as a function of energy gap ". The vertical and horizontal units are $\frac{S_{T_R}(0)}{2eI}$ and $2hc=_0$, respectively. The dashed-dotted line represents that if the free-space decay rate of the QR exciton is enhaced by a factor of 2 ($_0$! 2 $_0$), the shot noise is also enhanced.

To further understand the di erence between the QD and QR excitons, Fig. 4 illustrates the shot noise as a function of energy gap ". In plotting the gure, a perfect planarm icrocavity is assumed for convenience. As can be seen, the shot noise of the QD excitons shows the plateau feature (solid line) with the increasing of ", while it is a zigzag behavior (gray-dashed and dashed-dotted lines) for the QR excitons. This is because the decay rate of

the QD exciton in a microcavity is given by [16]

$$dot / \sum_{n_c} \frac{e^2 h}{m^2 c^2 L} (("=hc)^2 (n_c=L)^2) q^0 k_2^0$$
 (9)

where is the step function, and the sum mation is over the positive integers. Therefore, when the energy gap " is tuned above some resonant mode of the cavity, the decay rate is a constant before the next decay channel is opened. On the other hand, however, one knows that the decay rate for the QR exciton is not a constant between two resonant modes. This explains why the decay property for QR exciton is dierent from that for the QD exciton under the same photonic environment, and the di erence m ay be distinguished by the shot noise m easurem ents. From the experim ental point of view, di erent dependences on " are easier to be realized since it's alm ost im possible to vary the cavity length once the sam ple is prepared. A possible way to observe the mentioned e ects is to vary " around the discontinuous points and m easure the corresponding current noise.

A few remarks about the ring radius should be mentioned here. One should note that we do not give the speci c value of the ring radius in our model. Instead, a phenom enological value about the free-space decay rate $_{0}$ is used. The magnitudes of the tunnel rates are set relative to it. In general, the changing of radius will cer-

tainly a ect the shot noise. For example, because of the exciton-polariton (superradiant) e ect in the direction of circum ference, an increasing of ring radius will enhance the decay rate. In addition, the dipole moment of the QR exciton is also altered because of the varying of the wavefunction. All these can contribute to the variations of the decay rate and shot noise. In our previous study [15], we have shown that the decay rate is a monotonic increasing function on radius if the exciton is coherent in the quantum ring, i.e. free of scattering from impurities or in perfect boundaries. The dashed-dotted line in Fig. 4 shows the result for doubled free-space decay rate, i.e. $_0$! 2 $_0$. Although the noise is increased, the zigzag feature remains unchanged.

In conclusion, we have derived in this work the non-equilibrium current noise of QR excitons incorporated in a p-i-n junction surrounded by a planar microcavity. Some radiative decay properties of the one-dimensional QR exciton can be obtained from the observation of shot noise spectrum, which also shows extra information about the electron-side tunneling rate. Dierent noise feature between the QD and QR is pointed out, and deserved to be tested with present technologies.

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